

New England Biolabs Certificate of Analysis

Product Name: *NaeI*
Catalog Number: R0190S
Concentration: 10,000 U/ml
Unit Definition: One unit is defined as the amount of enzyme required to digest 1 µg pXba DNA in 1 hour at 37°C in a total reaction volume of 50 µl.
Packaging Lot Number: 10172458
Expiration Date: 12/2024
Storage Temperature: -20°C
Storage Conditions: 50 mM NaCl, 10 mM Tris-HCl (pH 7.4), 1 mM DTT, 0.1 mM EDTA, 50% Glycerol, 200 µg/ml BSA
Specification Version: PS-R0190S/L v1.0

NaeI Component List			
NEB Part Number	Component Description	Lot Number	Individual QC Result
R0190SVIAL	NaeI	10172455	Pass
B6004SVIAL	rCutSmart™ Buffer	10168651	Pass

Assay Name/Specification	Lot # 10172458
Protein Purity Assay (SDS-PAGE) NaeI is >95% pure as determined by SDS PAGE analysis using Coomassie Blue detection.	Pass
Non-Specific DNase Activity (16 Hour) A 50 µl reaction in CutSmart™ Buffer containing 1 µg of pXba DNA and a minimum of 100 Units of NaeI incubated for 16 hours at 37°C results in a DNA pattern free of detectable nuclease degradation as determined by agarose gel electrophoresis.	Pass
Ligation and Recutting (Terminal Integrity) After a 10-fold over-digestion of pXba DNA with NaeI, ~75% of the DNA fragments can be ligated with T4 DNA ligase in 16 hours at 16°C. Of these ligated fragments, >95% can be recut with NaeI.	Pass
Exonuclease Activity (Radioactivity Release) A 50 µl reaction in CutSmart™ Buffer containing 1 µg of a mixture of single and double-stranded [³ H] E. coli DNA and a minimum of 50 units of NaeI incubated for 4 hours at 37°C releases <0.1% of the total radioactivity.	Pass
Endonuclease Activity (Nicking)	Pass

Assay Name/Specification	Lot # 10172458
A 50 µl reaction in CutSmart™ Buffer containing 1 µg of supercoiled PhiX174 DNA and a minimum of 50 units of NaeI incubated for 4 hours at 37°C results in <10% conversion to the nicked form as determined by agarose gel electrophoresis.	

This product has been tested and shown to be in compliance with all specifications.

One or more products referenced in this document may be covered by a 3rd-party trademark. Please visit www.neb.com/trademarks for additional information.



YunJie Sun
Production Scientist
15 Dec 2022



Michael Tonello
Packaging Quality Control Inspector
15 Feb 2023